

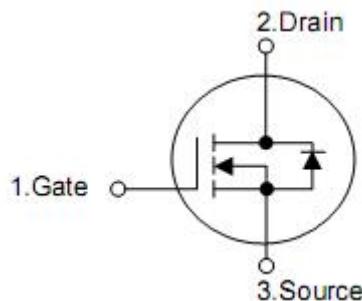
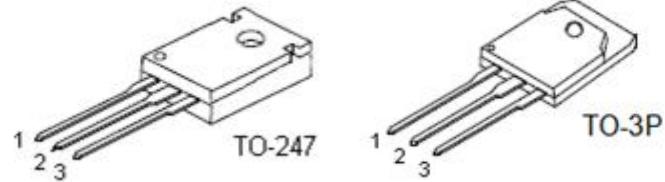
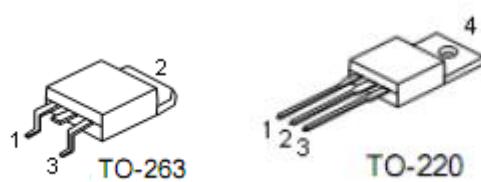
1. Features

- $R_{DS(on)}=4.0\text{m}\Omega$ (typ.) @ $V_{GS}=10\text{V}$
- 100% avalanche tested
- Reliable and rugged
- Lead free and green device available (RoHS Compliant)

2. Applications

- Switching application
- Power management for inverter systems

3. Symbol



Pin	Function
1	Gate
2	Drain
3	Source
4	Drain

4. Absolute maximum ratings

($T_A=25^\circ\text{C}$,unless otherwise noted)

Parameter	Symbol	Rating		Units
		TO-220/ TO-263	TO-247/ TO-3P	
Drain-source voltage	V_{DSS}	80		V
Gate-source voltage	V_{GSS}	± 25		V
Maximum junction temperature	T_J	175		$^\circ\text{C}$
Storage temperature range	T_{STG}	-55 to 175		$^\circ\text{C}$
Diode continuous forward current	I_S	150		A
Continuous drain current	I_D	150		A
		114		A
Pulse drain current*	I_{DM}	660**		A
Avalanche energy,single pulsed	E_{AS}	1.1***		J
Maximum power dissipation	P_D	178	214	W
		89	107	W

Note:
* Repetitive rating;pulse width limited by junction temperature

** Drain current is limited by junction temperature

*** $VD=64\text{V}$

5. Thermal characteristics

Parameter	Symbol	Rating	Unit
Thermal resistance,Junction-ambient	$R_{\theta JA}$	62.5	$^\circ\text{C/W}$
Thermal resistance,Junction-case	$R_{\theta JC}$	0.7	$^\circ\text{C/W}$

6. Electrical characteristics

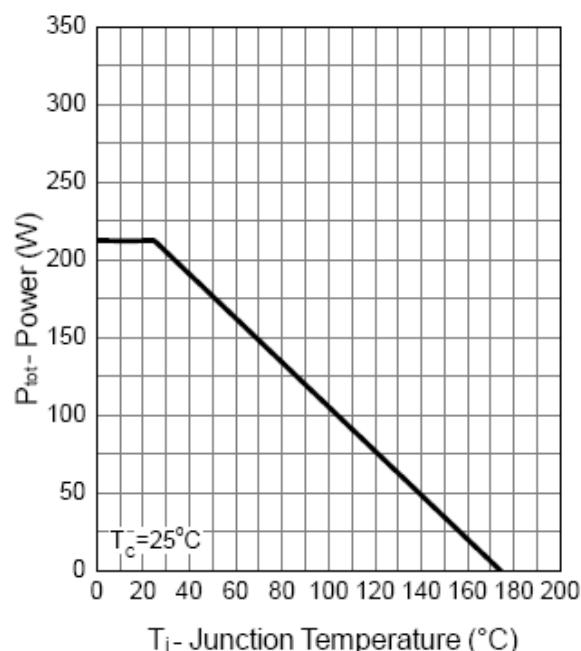
($T_A=25^\circ\text{C}$,unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
Drain-source breakdown voltage	BV_{DSS}	$V_{\text{GS}}=0\text{V}, I_{\text{DS}}=250\mu\text{A}$	80	-	-	V
Zero gate voltage drain current	I_{DSS}	$V_{\text{DS}}=80\text{V}, V_{\text{GS}}=0\text{V}$	-	-	1	μA
		$T_J=85^\circ\text{C}$	-	-	10	
Gate threshold voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250\mu\text{A}$	2.0	3.0	4.0	V
Gate leakage current	I_{GSS}	$V_{\text{GS}}=\pm 25\text{V}, V_{\text{DS}}=0\text{V}$	-	-	± 100	nA
Drain-source on-state resistance	$R_{\text{DS}(\text{on})}^*$	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=85\text{A}$	-	4.0	4.5	$\text{m}\Omega$
Gate resistance	R_g	$V_{\text{DS}}=0\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$	-	1.8	-	Ω
Diode forward voltage	V_{SD}^*	$I_{\text{SD}}=85\text{A}, V_{\text{GS}}=0\text{V}$	-	0.8	1.2	V
Reverse recovery time	t_{rr}	$I_{\text{SD}}=85\text{A},$ $dI_{\text{SD}}/dt=100\text{A}/\mu\text{s}$	-	30	-	nS
Reverse recovery charge	Q_{rr}		-	52	-	nC
Input capacitance	C_{iss}	$V_{\text{DS}}=25\text{V}, V_{\text{GS}}=0\text{V},$ $f=1\text{MHz}$	-	6109	-	pF
Output capacitance	C_{oss}		-	995	-	
Reverse transfer capacitance	C_{rss}		-	530	-	
Turn-on delay time	$t_{\text{d}(\text{on})}$	$V_{\text{DD}}=40\text{V}, I_{\text{DS}}=85\text{A},$ $R_G=6\Omega, V_{\text{GS}}=10\text{V}$	-	28	-	ns
Rise time	t_r		-	18	-	
Turn-off delay time	$t_{\text{d}(\text{off})}$		-	42	-	
Fall time	t_f		-	54	-	
Total gate charge	Q_g	$V_{\text{DS}}=64\text{V}, V_{\text{GS}}=10\text{V}$ $I_{\text{DS}}=85\text{A}$	-	152	-	nC
Gate-source charge	Q_{gs}		-	25	--	
Gate-drain charge	Q_{gd}		-	53	--	

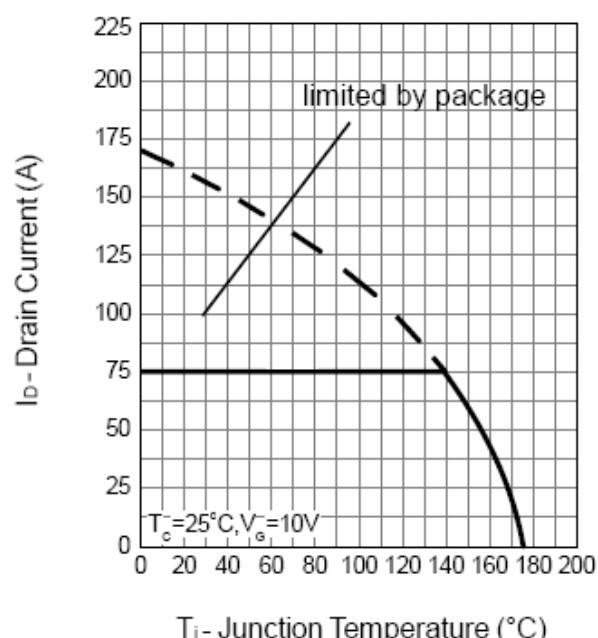
Note*:Pulse test;pulse width $\leq 300\text{us}$ duty cycle $\leq 2\%$.

7. Test circuits and waveforms

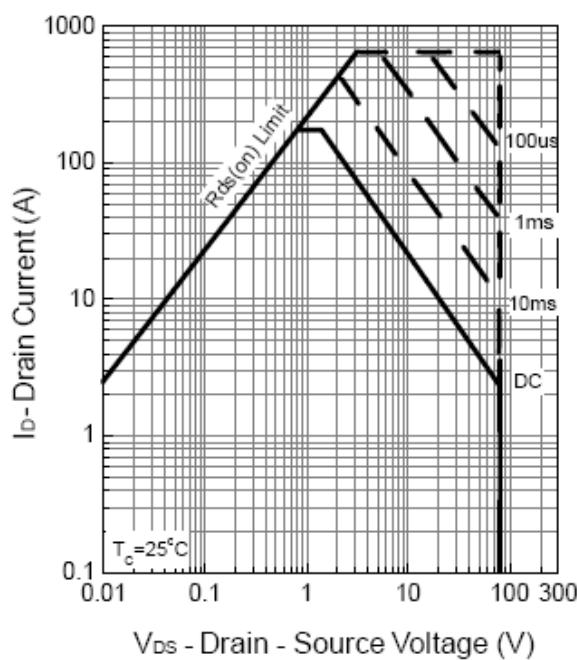
Power Dissipation



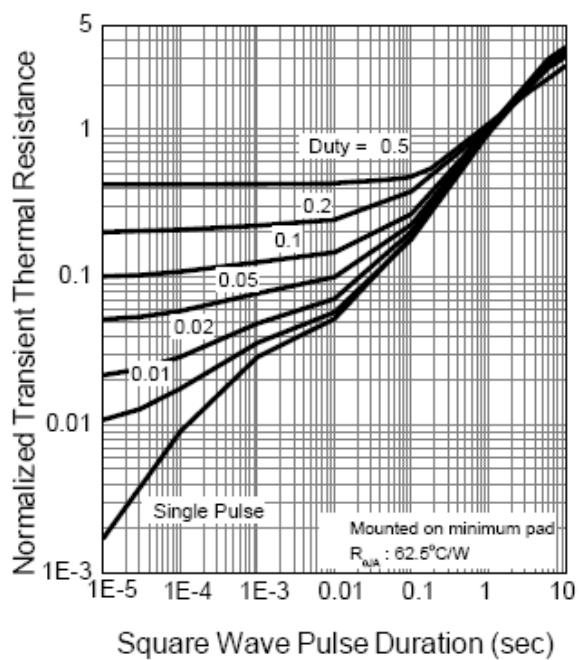
Drain Current

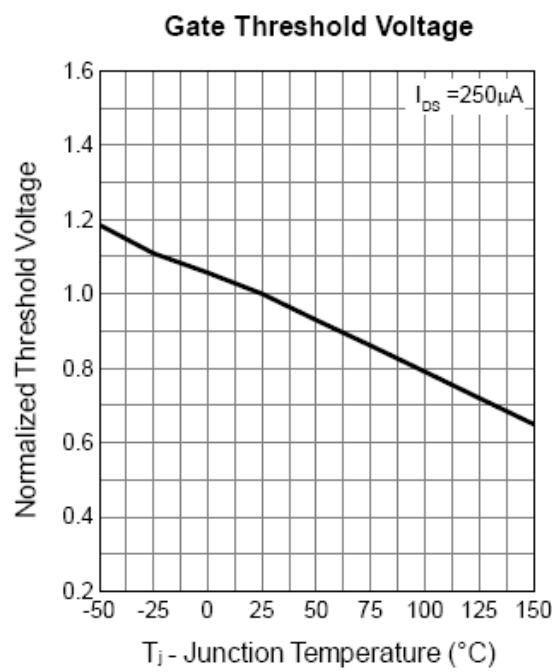
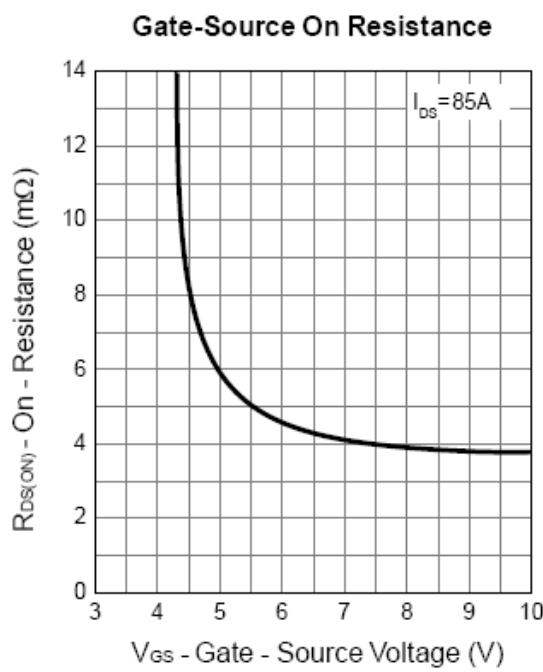
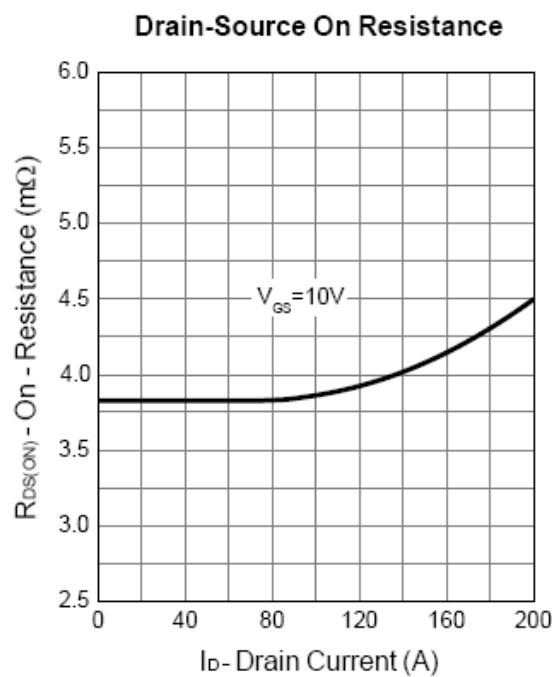
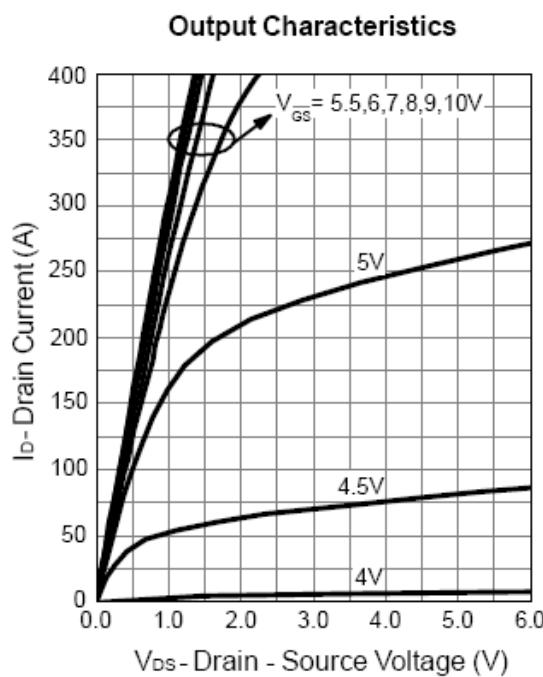


Safe Operation Area

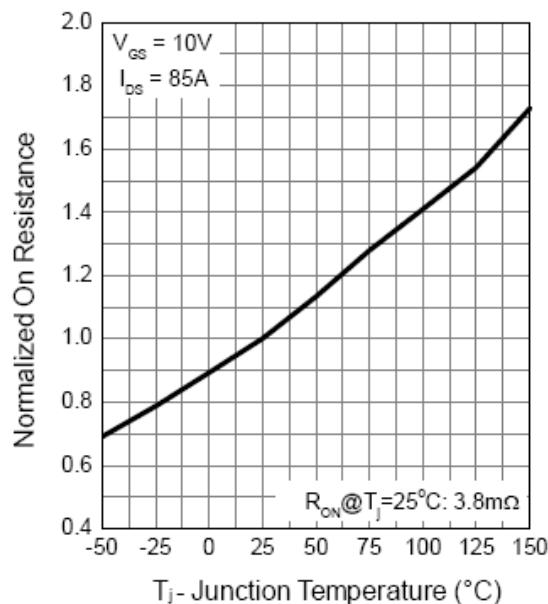


Thermal Transient Impedance

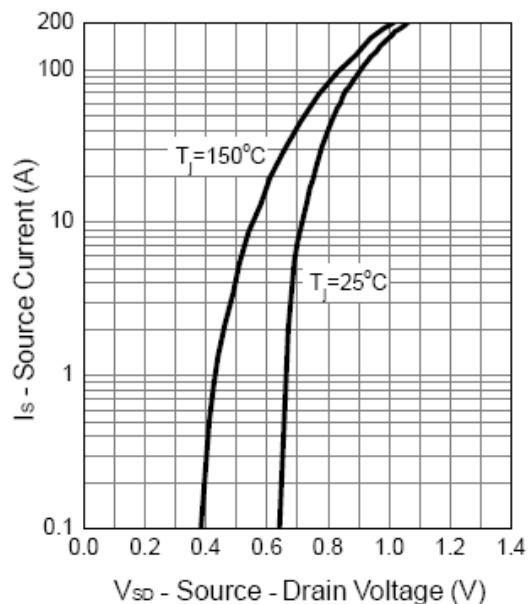




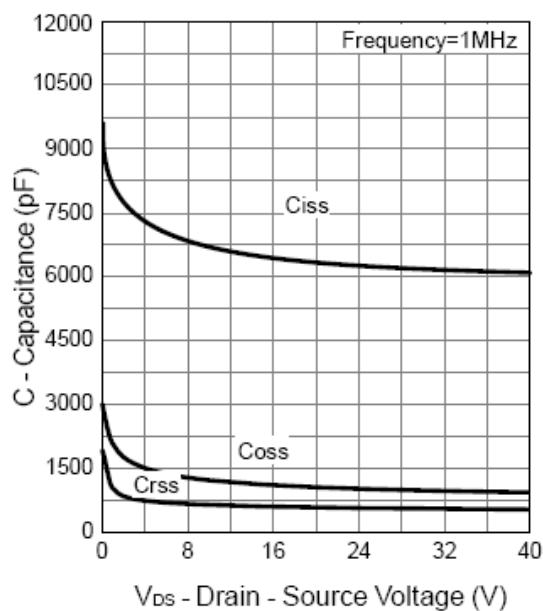
Drain-Source On Resistance



Source-Drain Diode Forward



Capacitance



Gate Charge

